## Issue Classification

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(Primary Examiner)

**ORIGINAL** 

JENNIFER Y CHO

Application/Control No.	Applicant(s)/Patent Under Reexamination							
10549630	ITOH ET AL.							
Examiner	Art Unit							

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INTERNATIONAL CLASSIFICATION

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			SUBCLASS					С	LAIMED	NON-CLAIMED						
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CROSS REFERENCE(S)																
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(Assistant Examiner) (Date)				20												
/Yvonne Eyler/							2/	/27/08	C	).G. F	⊃rint	Clain	n(s)	O.G. Print Figure		

(Date)

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